

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Manabu SAITO et al.

Group Art Unit: 2852

Application No.: 10/827,323

Examiner: Q. GRAINGER

Filed: April 20, 2004

Docket No.: 113539.01

For:

IMAGE FORMING APPARATUS AND PROCESS CARTRIDGE WITH DEVELOPER

STORAGE PORTION (AS AMENDED)

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits after the filing of a Request for Continued Examination under 37 CFR §1.114. No certification or fee is required.
- 2. One or more reference cited herein was cited in a counterpart foreign application. English language versions of Six (6) foreign Office Actions are attached for the Examiner's information. See References 4-16.
- 3. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 4. An English language Abstract of one or more non-English language reference is attached hereto. See References <u>4-15</u>.
- 5. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 4-11.

- 8. References 1-3 correspond to references 15, 4, and 5, respectively.
- 7. JP-A-07-168507 was previously submitted in an Information Disclosure Statement filed April 20, 2004. Therefore, a copy this reference is not attached.

Respectfully submitted,

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JAO:KDB/jam

Date: January 17, 2007

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE
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Form PTO-14 (REV. 1/06)	149 TRING	US Dept. of Cor PATENT & TRADEMARK (mmerce OFFICE	ATTY DOCKET NO. 113539.01			APPLICATION NO. 10/827,323		
INFORMATION DISCLOSURE STATEMENT									
(Use several sheets if necessary)				APPLICANT(S) Manabu SAITO et al.			·		
				FILING April 20			GROUP 2852		
		U	.S. PATEN	T DOCUN	MENTS		1		
Examiner Initials	Cite No.	Document Number	Da	ate	Name				
	1	5,291,254	03/01/1994		SHIMADA et al.				
	2	5,438,391	08/01/1995		MAEKAWA et al.				
	3	5,899,602	05/04/1999		NODA et al.				
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	4	JP-A-06-110262	04/22/1994		JAPAN		XX	XX	
	5	JP-A-08-305246	11/22/1996		JAPAN		XX	xx	
	6	JP-A-05-173375	07/13/1993		JAPAN		XX	xx	
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	11	JP-A-2000-356882	12/26/2	000	JAPAN		XX	XX	
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	14	JP-A-04-127167	04/28/1	992	JAPAN		XX		
	15	JP-A-04-318875	11/10/1	992	JAPAN		XX		
	16	JP-U-01-136944	09/19/1	989	JAPAN	<u>_</u>			
		_	OTHER	DOCUME	INTS				
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Date: January 17, 2007